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App	lication/C	ontrol	No.

Applicant(s)/Patent under Reexamination

10/825,131

NAKAGAWA ET AL.

Examiner

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Thong Q. Nguyen

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SEARCHED				
Class	Subclass	Date	Examiner	
359	368, 383, 391-394; 813-814	4/28/2005	NT	
359	823-824	4/29/2005	NT	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
359	391-394	4/29/2005	NT	
359	368	4/29/2005	NT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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